

### General Description

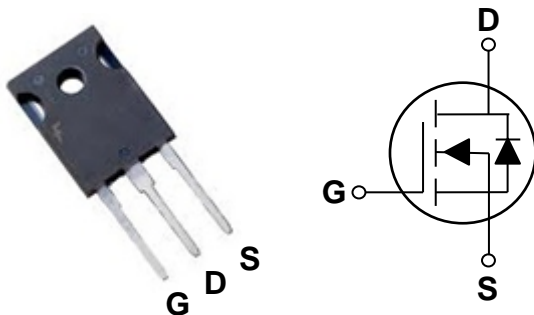
These N-Channel enhancement mode power field effect transistors are using trench DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency fast switching applications.

BVDSS	RDSON	ID
80V	2.6mΩ	250A

### Features

- 80V,250A,  $R_{DS(ON)} = 2.6m\Omega @ V_{GS} = 10V$
- Improved  $dv/dt$  capability
- Fast switching
- 100% EAS Guaranteed
- Green Device Available

### TO247 Pin Configuration



### Applications

- Networking
- Load Switch
- LED applications



### Absolute Maximum Ratings $T_c=25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Rating	Units
$V_{DS}$	Drain-Source Voltage	80	V
$V_{GS}$	Gate-Source Voltage	$\pm 20$	V
$I_D$	Drain Current – Continuous ( $T_c=25^\circ\text{C}$ )	250	A
	Drain Current – Continuous ( $T_c=100^\circ\text{C}$ )	155	A
$I_{DM}$	Drain Current – Pulsed <sup>1</sup>	1000	A
EAS	Single Pulse Avalanche Energy <sup>2</sup>	1280	mJ
IAS	Single Pulse Avalanche Current <sup>2</sup>	160	A
$P_D$	Power Dissipation ( $T_c=25^\circ\text{C}$ )	543	W
	Power Dissipation – Derate above $25^\circ\text{C}$	4.35	W/ $^\circ\text{C}$
$T_{STG}$	Storage Temperature Range	-50 to 150	$^\circ\text{C}$
$T_J$	Operating Junction Temperature Range	-50 to 150	$^\circ\text{C}$

### Thermal Characteristics

Symbol	Parameter	Typ.	Max.	Unit
$R_{\theta JA}$	Thermal Resistance Junction to ambient	---	62	$^\circ\text{C}/\text{W}$
$R_{\theta JC}$	Thermal Resistance Junction to Case	---	0.23	$^\circ\text{C}/\text{W}$

**Electrical Characteristics (T<sub>J</sub>=25 °C, unless otherwise noted)**
**Off Characteristics**

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V, I <sub>D</sub> =250uA	80	---	---	V
ΔBV <sub>DSS</sub> /ΔT <sub>J</sub>	BV <sub>DSS</sub> Temperature Coefficient	Reference to 25°C, I <sub>D</sub> =1mA	---	0.05	---	V/°C
I <sub>DSS</sub>	Drain-Source Leakage Current	V <sub>DS</sub> =80V, V <sub>GS</sub> =0V, T <sub>J</sub> =25°C	---	---	1	uA
		V <sub>DS</sub> =64V, V <sub>GS</sub> =0V, T <sub>J</sub> =125°C	---	---	10	uA
I <sub>GSS</sub>	Gate-Source Leakage Current	V <sub>GS</sub> =±25V, V <sub>DS</sub> =0V	---	---	±100	nA

**On Characteristics**

R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> =10V, I <sub>D</sub> =20A	---	2	2.6	mΩ
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>GS</sub> =V <sub>DS</sub> , I <sub>D</sub> =250uA	1.5	2.2	3.5	V
ΔV <sub>GS(th)</sub>	V <sub>GS(th)</sub> Temperature Coefficient		---	-5	---	mV/°C
g <sub>fs</sub>	Forward Transconductance	V <sub>DS</sub> =10V, I <sub>D</sub> =3A	---	18	---	S

**Dynamic and switching Characteristics**

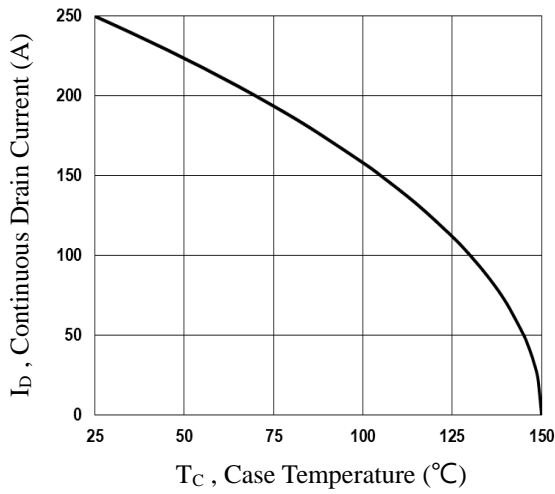
Q <sub>g</sub>	Total Gate Charge <sup>3,4</sup>	V <sub>DS</sub> =40V, V <sub>GS</sub> =10V, I <sub>D</sub> =10A	---	247	360	nC
Q <sub>gs</sub>	Gate-Source Charge <sup>3,4</sup>		---	63.5	125	
Q <sub>gd</sub>	Gate-Drain Charge <sup>3,4</sup>		---	56	110	
T <sub>d(on)</sub>	Turn-On Delay Time <sup>3,4</sup>	V <sub>DD</sub> =40V, V <sub>GS</sub> =10V, R <sub>G</sub> =10Ω I <sub>D</sub> =10A	---	71	140	ns
T <sub>r</sub>	Rise Time <sup>3,4</sup>		---	103	200	
T <sub>d(off)</sub>	Turn-Off Delay Time <sup>3,4</sup>		---	291	580	
T <sub>f</sub>	Fall Time <sup>3,4</sup>		---	170	340	
C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> =40V, V <sub>GS</sub> =0V, F=1MHz	---	16800	33000	pF
C <sub>oss</sub>	Output Capacitance		---	930	1860	
C <sub>rss</sub>	Reverse Transfer Capacitance		---	55	110	
R <sub>g</sub>	Gate resistance	V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, F=1MHz	---	1.8	3.6	Ω

**Drain-Source Diode Characteristics and Maximum Ratings**

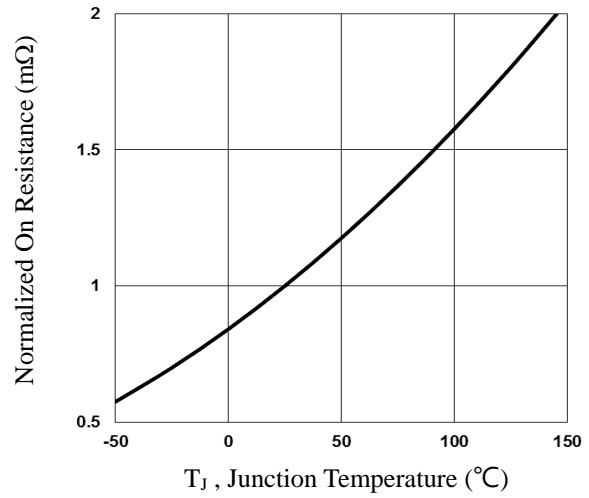
Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
I <sub>S</sub>	Continuous Source Current	V <sub>G</sub> =V <sub>D</sub> =0V, Force Current	---	---	250	A
I <sub>SM</sub>	Pulsed Source Current		---	---	500	A
V <sub>SD</sub>	Diode Forward Voltage	V <sub>GS</sub> =0V, I <sub>S</sub> =1A, T <sub>J</sub> =25°C	---	---	1	V
t <sub>rr</sub>	Reverse Recovery Time	V <sub>GS</sub> =0V, I <sub>S</sub> =20A, di/dt=100A/μs	---	54	---	ns
Q <sub>rr</sub>	Reverse Recovery Charge	T <sub>J</sub> =25°C	---	78	---	nC

Note :

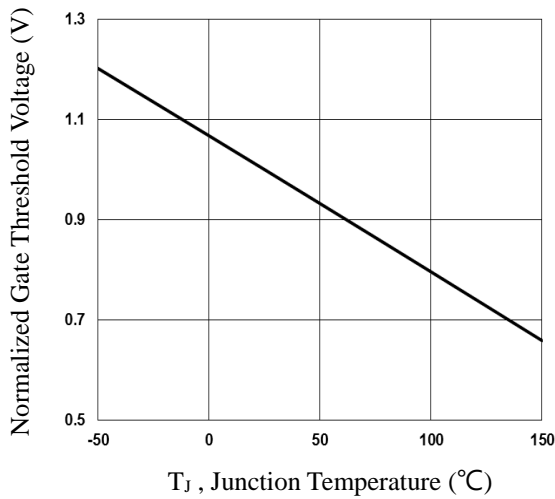
1. Repetitive Rating : Pulsed width limited by maximum junction temperature.
2. V<sub>DD</sub>=50V, V<sub>GS</sub>=10V, L=0.1mH, I<sub>AS</sub>=160A., Starting T<sub>J</sub>=25°C
3. The data tested by pulsed, pulse width ≤ 300us, duty cycle ≤ 2%.
4. Essentially independent of operating temperature.



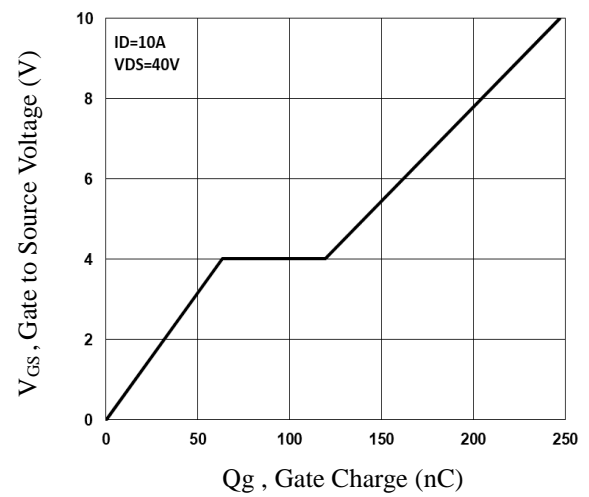
**Fig.1 Continuous Drain Current vs.  $T_C$**



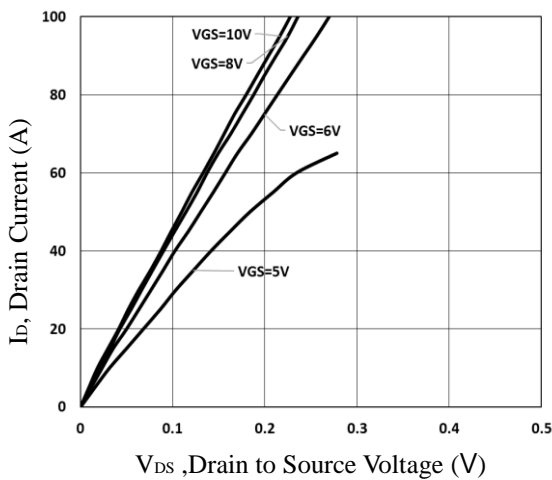
**Fig.2 Normalized  $R_{DS(on)}$  vs.  $T_J$**



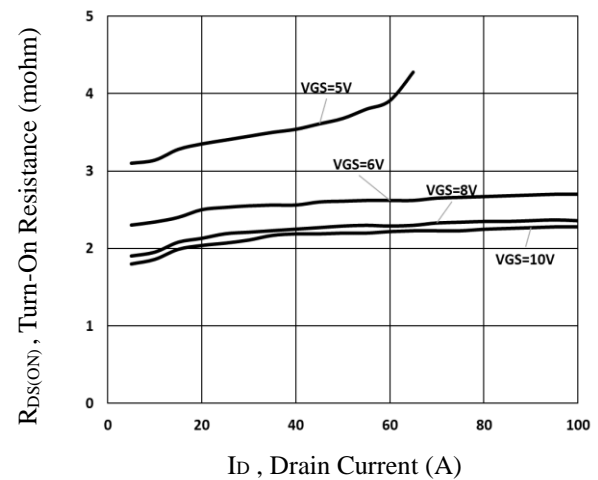
**Fig.3 Normalized  $V_{th}$  vs.  $T_J$**



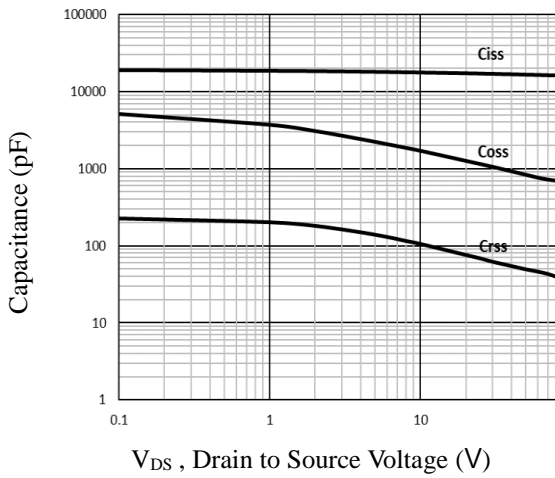
**Fig.4 Gate Charge Characteristics**



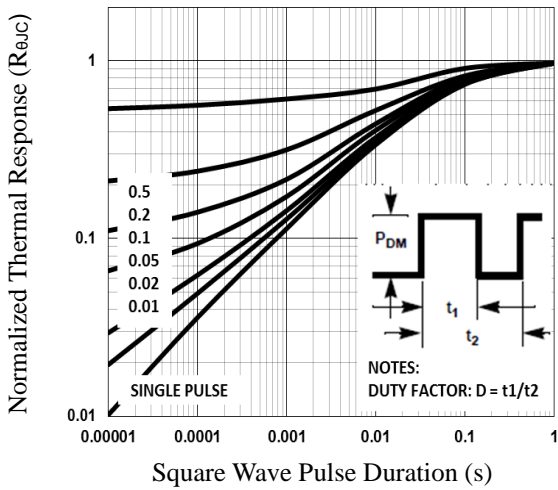
**Fig.5 Typical Output Characteristics**



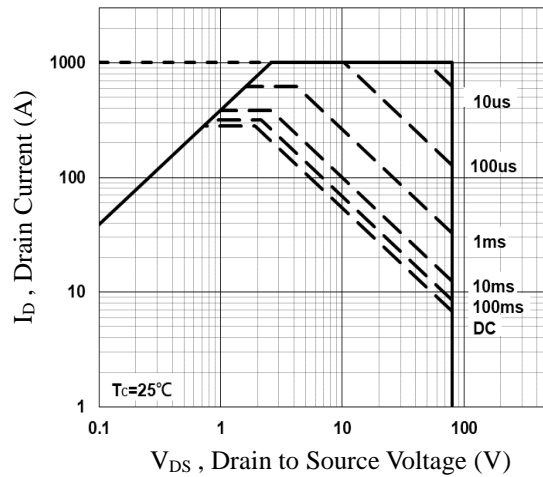
**Fig.6 Turn-On Resistance vs.  $I_D$**



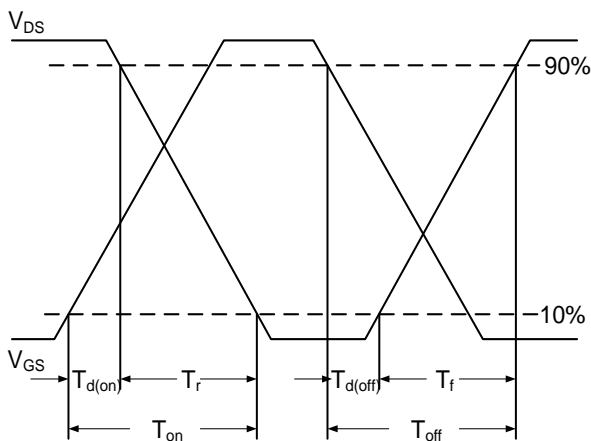
**Fig.7 Capacitance Characteristics**



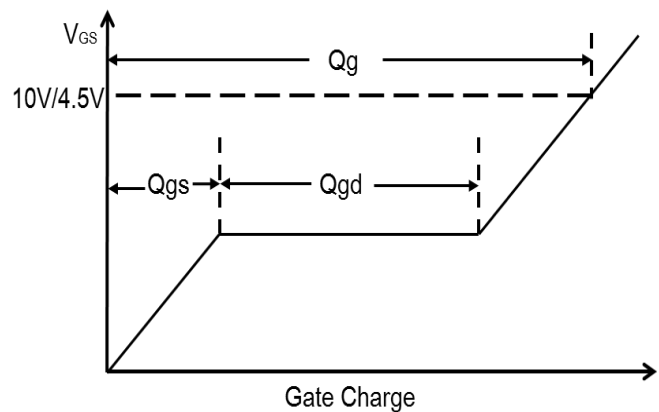
**Fig.8 Normalized Transient Impedance**



**Fig.9 Maximum Safe Operation Area**



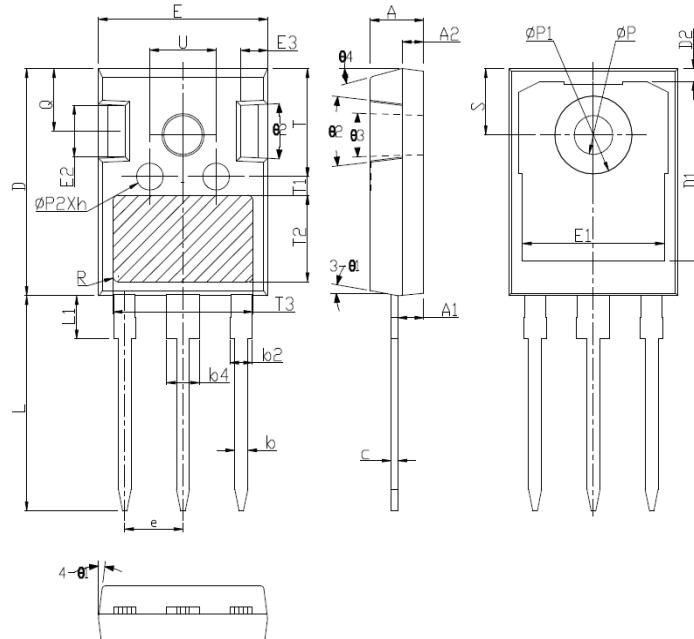
**Fig.10 Switching Time Waveform**



**Fig.11 Gate Charge Waveform**



**TO247 PACKAGE INFORMATION**



Symbol	Dimensions In Millimeters			Symbol	Dimensions In Millimeters		
	Min	Nom	Max		Min	Nom	Max
A	4.750	5.000	5.250	L	19.520	19.920	20.320
A1	2.160	2.410	2.660	L1	---	---	4.300
A2	1.850	2.000	2.150	ΦP	3.350	3.600	3.850
b	1.110	1.200	1.350	ΦP1	---	---	7.300
b2	1.900	2.010	2.250	ΦP2	2.250	2.500	2.750
b4	2.900	3.100	3.250	Q	5.500	5.800	6.100
c	0.510	0.610	0.750	S	6.15BSC		
D	20.600	21.000	21.400	R	0.50REF		
D1	16.150	16.550	16.950	T	9.700	---	10.300
D2	1.000	1.200	1.400	T1	1.65REF		
E	15.500	15.800	16.100	T2	8.00REF		
E1	13.000	13.300	13.600	T3	12.80REF		
E2	4.700	5.000	5.300	U	5.900	---	6.500
E3	2.250	2.500	2.750	θ1	3°	7°	10°
e	5.44BSC			θ2	2°	5°	8°
h	0.000	0.100	0.250	θ3	1°	---	2°
				θ4	10°	15°	20°